## Application/Control No. Applicant(s)/Patent Under Reexamination 10/689,717 NISHIMURA, NAOKI Notice of References Cited Art Unit Examiner Page 1 of 1 Tan 2818 T. Nguyen **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 09-2003 Hayashi et al. 365/158 US-6,628,542 Α В US-С US-D US-E US-US-F US-G US-Н 1 US-US-US-US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification Country MM-YYYY N 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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